REV	DATE	REVISION RECORD	DWN	AUTH
-	04-24-14	Initial Release	Liz	



GENERAL REQUIREMENTS			REV	DATE	REVISION RECORD	DWN	AUTH
Material, Design and Construction	MIL-PRF-55310		-	04-24-14	Initial Release	Liz	
Parts and Materials List	Supplied						
Parts, Materials	EEE-INST-002 Level 2 at a minimum, JANS Semiconductors,						
•	Class S Passives and ICs, when available.						
Crystal	Premium Q, Z-swept, synthetic quartz						
Traceability	Semiconductor and passive lot and date code tracking						
De-rating	per EEE-INST-002. (JPL-D-8545. alternative)						
Soldering	J-STD-001 class 3						
Case	Nickel-plated steel housing	500.00	000 04		EM Explore size Medal		
Finish	Electroless nickel per MIL-C-26074	500-28	8039-01		ENI Engineering Model		
ELECTRICAL PERFORMANCE		500-28	8039-02		Qualification Model		
RF Output Frequency	50.0 MHz, sine wave	500.29	000 00		EM Elight Model		
Frequency Accuracy (initial)	±1 x 10 ^{-°} at +25℃	500-20	003-00				
Frequency Stability	±8 x 10 ⁻⁶ for -10°C to +50°C (ref +25°C)						
Aging Rate (after 90 days operating)	6						
1 year	$\pm 2 \times 10^{-5}$						
RF Output Power	+7 dBm ±2.5dB into 50Ω						
RF Output Harmonics	-30 dBc						
RF Output Spurious	<-80 gBC						
100 Hz	-115 dBc/Hz						
1 KHz	-135 dBc/Hz						
10 KHz	-163 dBc/Hz						
Supply voltage	+10 \pm 0.5 VDC, regulated and filtered						
Input power	<0.5 watts steady state at ambient pressure $<5 \times 10^{-3}$ torr						
ENVIRONMENTAL CONDITIONS							
Operating temperature	-10°C to +50°C						
Storage temperature	-40°C to +105°C						
Design / Qualification	-10°C to +50°C						
Ambient pressure	Atmospheric (760 torr), Vacuum (<5 x 10 ⁻⁵ torr)						
Radiation, design to meet	TID 100 krads Si						
MECHANICAL SPECIFICATIONS							
Size	1.610" x 1.0" x 0.5"						
Weight	<150 grams						
Physical	Pressure relief hole						
Model Definitions							
EM (Engineering Model)	Design and Construction similar in appearance and identical						
,	in form, fit, and function to FM. Developed using best						
	commercial practice, including commercial parts and						
	materials. EM shall be subjected only to electrical tests, with	1	1				
no environmental testing performed.					Wenzel Associates. Inc.		
FM (Flight Model)	Fabricated to meet all design, construction, and test				Austin, Texas		
(3)	requirements. FM shall be subjected to the entire compliment		Title:				
	of electrical and environmental acceptance tests.			50	MHz Space Crystal Oscillat	or	
OM(Qualification Model)	Fabricated and tested as an FM unit with the addition of		P/N:		Rev: Date: Drawn:	Ref:	
	Qualification tests.		500)-28039	- 04-24-14	1	5895
			Toloropoosi				
			(except as no	oted)		Page 2 of	3
			Dimensions a	are in inches	± 0.030 ± 0.010 02021	i age 🗖 Of	5

QUALIFICATION TESTS (Non-flight model, only)

Group I (6 samples) Burn-In (operational) Group II (6 samples) Aging

240 hours minimum at +60°C 30 Days

Visual, Electrical Tests*

Group III Subgroup 1 (6 samples) Random Vibration

Shock

Group III Subgroup 2 (3 samples) Thermal Shock

Ambient Pressure Group III Subgroup 3 (1 sample) Resistance to Soldering Heat Group III Subgroup 4 (1 sample) Terminal Strength

Solderability Resistance to Solvents

Electrical Tests* Radiographics

11.95 Grms, MIL-STD-202, method 214 I-D, 50 to 2000 Hz, 5 min per axis MIL-STD-202, Method 213, Condition A, 50G, 11msec MIL-STD-202, Method 107, Condition A-1,

25 cycles, -55°C to +85°C MIL-STD-202, Method 105, at <5 x 10⁻⁵ torr

MIL-STD-202, Method 210, Condition A

MIL-STD-202, Method 211, Condition C, Not applicable for pins <0.25" MIL-STD-202, Method 208 MIL-STD-202. Method 215 Not applicable when marking is electro-etched

MIL-STD-202, method 209

ACCEPTANCE TESTS (Flight Model)

Electrical Tests* Thermal Shock

MIL-STD-202. Method 107. Condition A. 5 Cycles, -55°C to +85°C Random Vibration (non-operational) 7.56 Grms overall, 50 to 2000 Method 214 I-B, 50 to 2000 Hz, 5 min per axis

Electrical Tests* Burn-In (operational) Aging Rate Electrical Tests* Radiographics

240 hours minimum at +60°C Projected after 30 days operating MIL-STD-202, method 209

*ELECTRICAL TESTS

Tested at standard pressure and at -10, +10, +25, +40, +50 ℃ unless otherwise noted

Input Power Cold Start (-10 ℃) Hot Start (+50 ℃) RF Output Power **RF** Output Harmonics RF Output Spurious Frequency Accuracy (+25 °C only) Frequency Stability Phase Noise - Static (+25°C only, 760 torr)

ANALYSES

Thermal Analysis, Component Stress Analysis

Wenzel Associates, Inc. Austin, Texas Title: 50 MHz Space Crystal Oscillator								
501-28039	-	04-24-14			15895			
Tolerances: (except as noted) Dimensions are in inches	0.XX Dec: ±0.03	0"	0.XXX Dec: ±0.010"	FSCM: 62821	Page 3 of 3			

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